

SILICON POWER MOS FET NE5510279A

4.8 V OPERATION SILICON RF POWER LD-MOS FET FOR 1.8 GHz 2 W TRANSMISSION AMPLIFIERS

DESCRIPTION

The NE5510279A is an N-channel silicon power MOS FET specially designed as the transmission power amplifier for 4.8 V GSM 1 800 handsets. Dies are manufactured using our NEWMOS technology (our 0.6 μ m WSi gate lateral-diffusion MOS FET) and housed in a surface mount package. The device can deliver 33.0 dBm output power with 47% power added efficiency at 1.8 GHz under the 4.8 V supply voltage.

FEATURES

High output power
 Pout = 35.5 dBm TYP. (VDS = 4.8 V, IDset = 300 mA, f = 900 MHz, Pin = 25 dBm)

: Pout = 33.0 dBm TYP. (VDS = 4.8 V, IDset = 300 mA, f = 1.8 GHz, Pin = 25 dBm)

• High power added efficiency : $\eta_{add} = 65\%$ TYP. (VDS = 4.8 V, IDset = 300 mA, f = 900 MHz, Pin = 25 dBm)

: $\eta_{add} = 47\%$ TYP. (VDS = 4.8 V, IDset = 300 mA, f = 1.8 GHz, Pin = 25 dBm)

High linear gain
 G_L = 16.0 dB TYP. (V_{DS} = 4.8 V, I_{Dset} = 300 mA, f = 900 MHz, P_{in} = 10 dBm)

: GL = 10.0 dB TYP. (VDS = 4.8 V, IDset = 300 mA, f = 1.8 GHz, Pin = 10 dBm)

Surface mount package : 5.7 × 5.7 × 1.1 mm MAX.

• Single supply : V_{DS} = 3.0 to 6.0 V

APPLICATIONS

• Digital cellular phones : 4.8 V GSM 1 800 class 1 handsets

Others : General purpose amplifiers for 1.6 to 2.0 GHz TDMA applications

ORDERING INFORMATION

Part Number	Package	Marking	Supplying Form
NE5510279A-T1	79A	W2	12 mm wide embossed taping Gate pin face the perforation side of the tape Qty 1 kpcs/reel

Remark To order evaluation samples, consult your NEC sales representative.

Part number for sample order: NE5510279A

Caution Observe precautions when handling because these devices are sensitive to electrostatic discharge.

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ABSOLUTE MAXIMUM RATINGS (TA = +25°C)

Parameter	Symbol	Ratings	Unit
Drain to Source Voltage	Vos	20.0	V
Gate to Source Voltage	Vgs	5.0	V
Drain Current	Ips	1.0	Α
Drain Current (Pulse Test)	IDS Note	2.0	Α
Total Power Dissipation	Ptot	20	W
Channel Temperature	Tch	125	°C
Storage Temperature	Tstg	-65 to +125	°C

Note Duty Cycle $\leq 50\%$, Ton $\leq 1 \text{ s}$

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Drain to Source Voltage	Vos		3.0	4.8	6.0	V
Gate to Source Voltage	Vgs		0	2.0	3.5	V
Drain Current (Pulse Test)	Ids	Duty Cycle ≤ 50%, Ton ≤ 1 s	-	1.0	1.5	Α
Input Power	Pin	f = 1.8 GHz, V _{DS} = 4.8 V	25	-	27	dBm



ELECTRICAL CHARACTERISTICS (TA = +25°C)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Gate to Source Leak Current	Igss	Vgss = 5.0 V	-	-	100	nA
Saturated Drain Current (Zero Gate Voltage Drain Current)	Ipss	V _{DSS} = 8.5 V	-	-	100	nA
Gate Threshold Voltage	Vth	V _{DS} = 4.8 V, I _{DS} = 1 mA	1.0	1.35	2.0	V
Transconductance	gm	V _{DS} = 4.8 V, I _{DS} = 600 mA	-	1.50	-	S
Drain to Source Breakdown Voltage	BVDSS	$loss = 10 \mu A$	20	24	-	V
Thermal Resistance	Rth	Channel to Case	-	5	-	°C/W
Linear Gain	GL	f = 900 MHz, P _{in} = 10 dBm, V _{DS} = 4.8 V, I _{Dset} = 300 mA, Note 1, 2	-	16.0	-	dB
Output Power	Pout	f = 900 MHz, Pin = 25 dBm,	_	35.5	-	dBm
Operating Current	lop	V _{DS} = 4.8 V, I _{Dset} = 300 mA, Note 1, 2	_	1 000	-	mA
Power Added Efficiency	η add		-	65	-	%
Linear Gain	GL	f = 1.8 GHz, P _{in} = 10 dBm, V _{DS} = 4.8 V, I _{Dset} = 300 mA, Note 1, 2	-	10.0	-	dB
Output Power	Pout	f = 1.8 GHz, Pin = 25 dBm,	32.0	33.0	-	dBm
Operating Current	lop	V _{DS} = 4.8 V, I _{Dset} = 300 mA, Note 1, 2	_	750	-	mA
Power Added Efficiency	η add		38	47		%

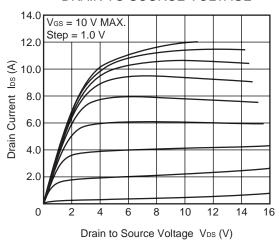
Notes 1. Peak measurement at Duty Cycle \leq 50%, $T_{on} \leq$ 1 s.

2. DC performance is 100% testing. RF performance is testing several samples per wafer. Wafer rejection criteria for standard devices is 1 reject for several samples.

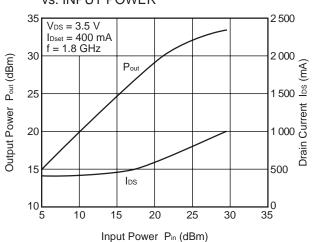
Data Sheet PU10121EJ02V0DS

TYPICAL CHARACTERISTICS (TA = +25°C)

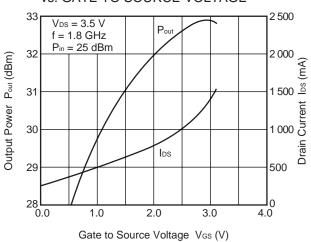
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



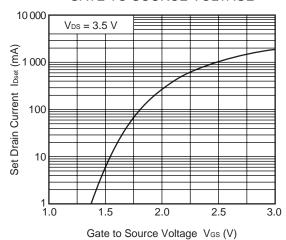
OUTPUT POWER, DRAIN CURRENT vs. INPUT POWER



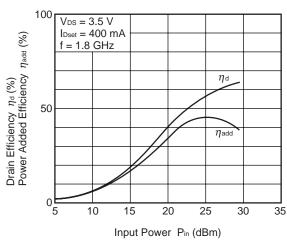
OUTPUT POWER, DRAIN CURRENT vs. GATE TO SOURCE VOLTAGE



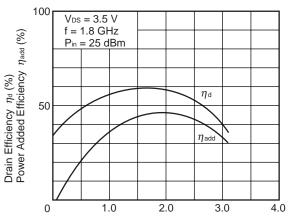
SET DRAIN CURRENT vs. GATE TO SOURCE VOLTAGE



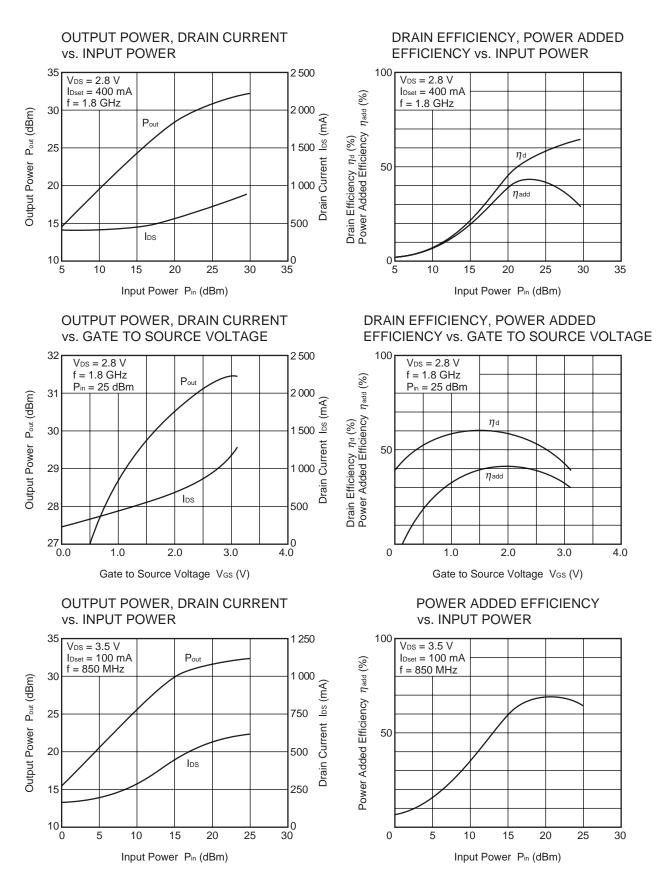
DRAIN EFFICIENCY, POWER ADDED EFFICIENCY vs. INPUT POWER



DRAIN EFFICIENCY, POWER ADDED EFFICIENCY vs. GATE TO SOURCE VOLTAGE



Gate to Source Voltage Vgs (V)



Remark The graphs indicate nominal characteristics.

S-PARAMETERS

Test Conditions: VDS = 3.5 V, IDset = 400 mA

Frequency	5	S ₁₁		S ₂₁			S 12		S	S ₂₂	MAG Note	MSG Note	K
GHz	MAG.	ANG.	dB	MAG.	ANG.	dB	MAG.	ANG.	MAG.	ANG.	dB	dB	
0.1	0.889	-149.7	18.8	8.66	99.8	-34.4	0.019	14.6	0.854	-173.8		26.6	
0.2	0.872	-165.4	12.9	4.41	87.5	-34.0	0.020	3.4	0.861	–177.7		23.4	
0.3	0.871	-170.9	9.3	2.91	82.0	-34.0	0.020	-1.8	0.875	-178.6		21.6	
0.4	0.871	-173.7	6.6	2.13	76.1	-34.4	0.019	-4.1	0.869	-179.6		20.5	
0.5	0.873	-175.6	4.6	1.69	71.5	-34.4	0.019	-9.5	0.886	179.7		19.5	0.04
0.6	0.880	-176.9	2.7	1.37	67.7	-34.9	0.018	-11.8	0.886	179.2		18.8	0.22
0.7	0.884	-177.9	1.4	1.17	63.9	-35.9	0.016	-10.6	0.893	178.9		18.6	0.40
0.8	0.897	-179.1	-0.1	0.99	60.5	-35.9	0.016	-10.2	0.898	178.0		17.9	0.40
0.9	0.905	-179.9	-1.2	0.87	56.3	-37.1	0.014	-15.0	0.914	177.6		17.9	0.41
1.0	0.919	178.1	-2.3	0.77	53.8	-37.1	0.014	-7.8	0.928	176.0		17.4	0.16
1.1	0.930	175.9	-3.2	0.69	48.8	-38.4	0.012	-13.7	0.938	174.8		17.6	0.11
1.2	0.923	174.2	-4.4	0.60	46.9	-38.4	0.012	-11.0	0.927	172.9		17.0	0.59
1.3	0.919	172.9	-5.4	0.54	42.6	-40.0	0.010	-10.5	0.923	171.8	14.1		1.29
1.4	0.918	171.8	-6.4	0.48	41.0	-40.0	0.010	-4.7	0.922	170.6	12.2		1.62
1.5	0.918	170.6	-7.1	0.44	37.6	-39.2	0.011	-8.0	0.924	170.1	11.7		1.53
1.6	0.920	168.9	-7.7	0.41	36.7	-41.9	0.008	-5.5	0.927	168.7	10.4		2.46
1.7	0.918	167.5	-8.9	0.36	33.6	-41.9	0.008	4.3	0.922	167.9	8.5		3.27
1.8	0.927	166.2	-9.1	0.35	30.9	-40.9	0.009	12.5	0.935	165.9	10.3		1.95
1.9	0.922	164.1	-10.2	0.31	28.2	-43.1	0.007	20.9	0.932	164.9	7.9		3.67
2.0	0.923	162.6	-10.5	0.30	27.8	-43.1	0.007	32.4	0.942	163.0	8.6		3.08
2.1	0.928	159.9	-11.7	0.26	25.2	-43.1	0.007	48.5	0.928	161.8	6.2		4.46
2.2	0.926	158.6	-12.0	0.25	23.2	-44.4	0.006	36.8	0.938	160.0	6.3		4.89
2.3	0.929	156.6	-13.2	0.22	20.0	-41.9	0.008	50.0	0.935	157.6	5.4		4.01
2.4	0.925	154.5	-13.2	0.22	18.0	-40.9	0.009	45.1	0.945	156.2	6.2		3.01
2.5	0.928	152.2	-14.0	0.20	18.1	-43.1	0.007	61.4	0.941	154.5	4.8		4.77
2.6	0.933	150.4	-14.0	0.20	17.2	-40.9	0.009	56.3	0.938	152.5	5.2		3.43
2.7	0.930	148.4	-15.9	0.16	15.0	-39.2	0.011	70.0	0.933	150.3	2.5		4.13
2.8	0.929	146.2	-15.4	0.17	11.1	-37.7	0.013	59.4	0.952	148.1	5.4		2.01
2.9	0.931	144.4	-15.9	0.16	11.6	-37.7	0.013	74.0	0.937	146.9	3.2		3.01
3.0	0.933	142.6	-16.5	0.15	10.0	-37.1	0.014	67.5	0.950	145.0	4.3		2.10

Note When K \geq 1, the MAG (Maximum Available Gain) is used. $MAG = \left| \frac{S_{21}}{S_{12}} \right| \left(K - \sqrt{(K^2 - 1)} \right)$ When K < 1, the MSG (Maximum Stable Gain) is used. $MSG = \left| \frac{S_{21}}{S_{12}} \right|, K = \frac{1 + \left| \Delta \right|^2 - \left| S_{11} \right|^2 - \left| S_{22} \right|^2}{2 \cdot \left| S_{12} \right| \cdot \left| S_{21} \right|},$ $\Delta = S_{11} \cdot S_{22} - S_{21} \cdot S_{12}$

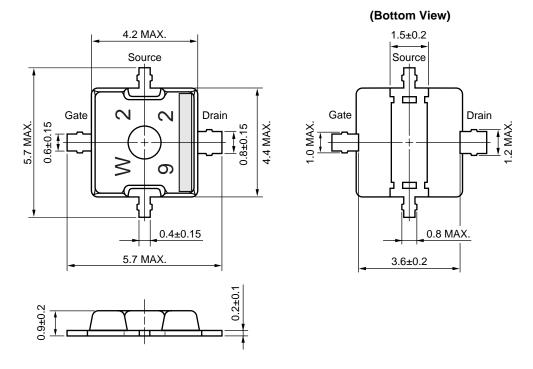
LARGE SIGNAL IMPEDANCE (VDS = 3.5 V, IDset = 400 mA, Pin = 25 dBm)

f (GHz)	Zin (Ω)	Z OL $(\Omega)^{Note}$
1.8	TBD	TBD

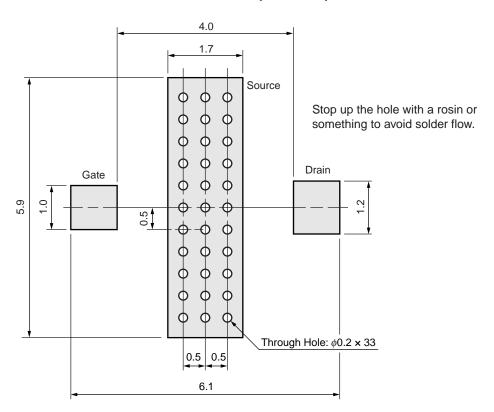
Note ZoL is the conjugate of optimum load impedance at given voltage, idling current, input power and frequency.

PACKAGE DIMENSIONS

79A (UNIT: mm)



79A PACKAGE RECOMMENDED P.C.B. LAYOUT (UNIT: mm)





RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

Soldering Method	Soldering Conditions		Condition Symbol
Infrared Reflow	Peak temperature (package surface temperature) Time at peak temperature Time at temperature of 220°C or higher Preheating time at 120 to 180°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 60 seconds or less : 120±30 seconds : 3 times : 0.2%(Wt.) or below	IR260
VPS	Peak temperature (package surface temperature) Time at temperature of 200°C or higher Preheating time at 120 to 150°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 215°C or below : 25 to 40 seconds : 30 to 60 seconds : 3 times : 0.2%(Wt.) or below	VP215
Wave Soldering	Peak temperature (molten solder temperature) Time at peak temperature Preheating temperature (package surface temperature) Maximum number of flow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 120°C or below : 1 time : 0.2%(Wt.) or below	WS260
Partial Heating	Peak temperature (pin temperature) Soldering time (per pin of device) Maximum chlorine content of rosin flux (% mass)	: 350°C or below : 3 seconds or less : 0.2%(Wt.) or below	HS350-P3

Caution Do not use different soldering methods together (except for partial heating).

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▶Business issue

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▶Technical issue

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